

<b>Notice of References Cited</b>	Application/Control No. 10/687,288	Applicant(s)/Patent Under Reexamination YUEH ET AL.	
	Examiner Daborah Chacko-Davis	Art Unit 1756	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-5,358,599	10-1994	Cathey et al.	438/701
	C	US-2004/0204328	10-2004	Zhang et al.	510/175
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	K	US-			
	L	US-			
	M	US-			

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	N					
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**NON-PATENT DOCUMENTS**

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